

## Supporting Information

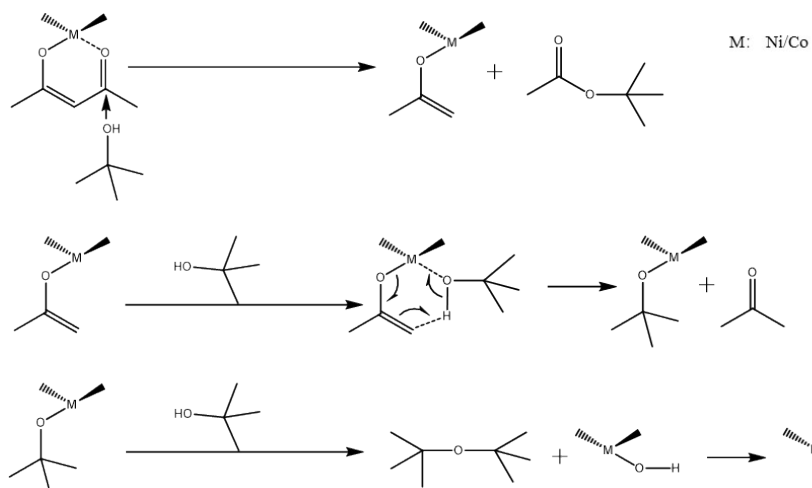
# Interlaced NiCoO<sub>2</sub> nanoparticle/nanosheet films for electrochromic energy storage devices with wide-band optical modulation and robust stability

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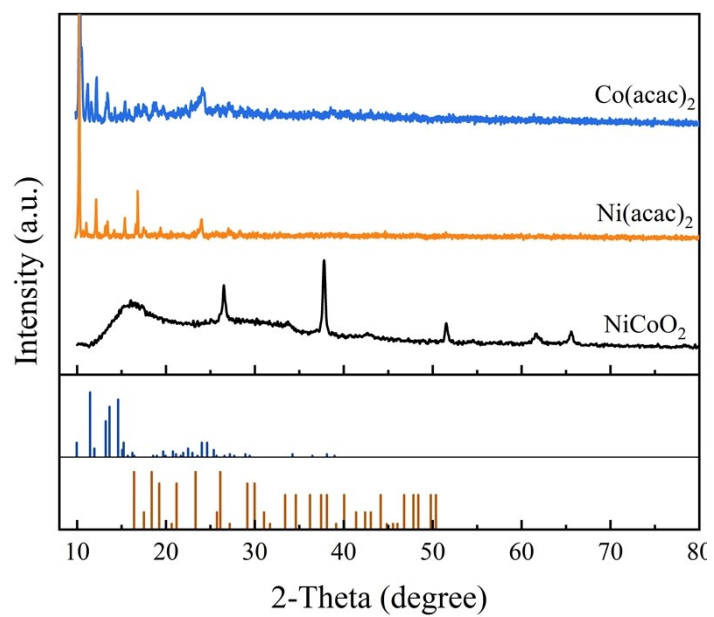
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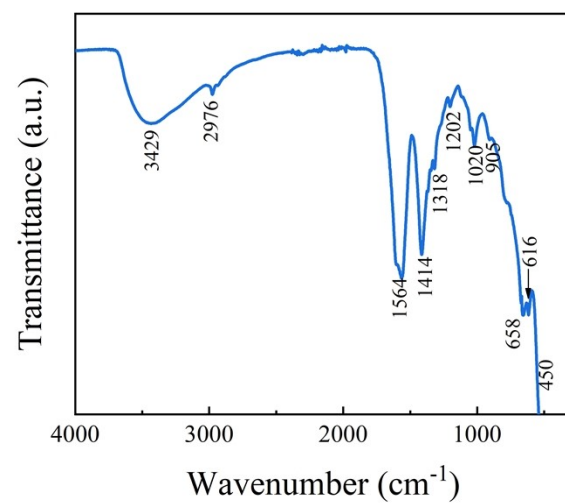
*‡ Yongchao Liu and Yu Zhong contributed equally to this work.*



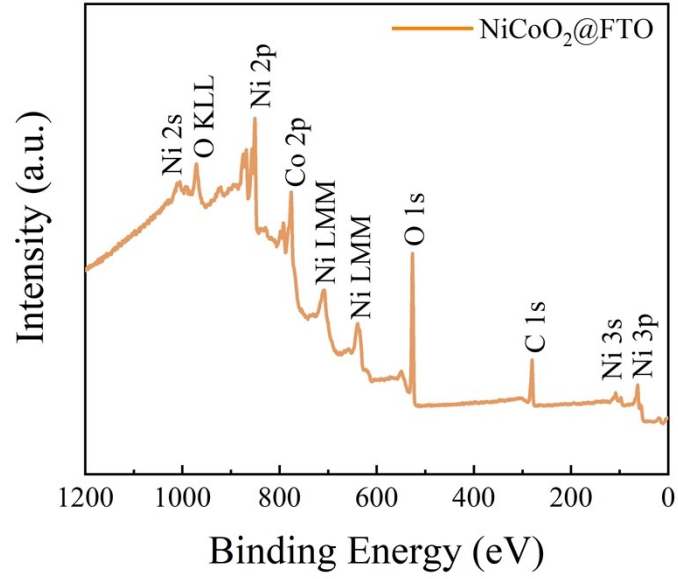
**Fig. S1** Schematic diagram of the reaction process of NiCoO<sub>2</sub> using the solvothermal method.



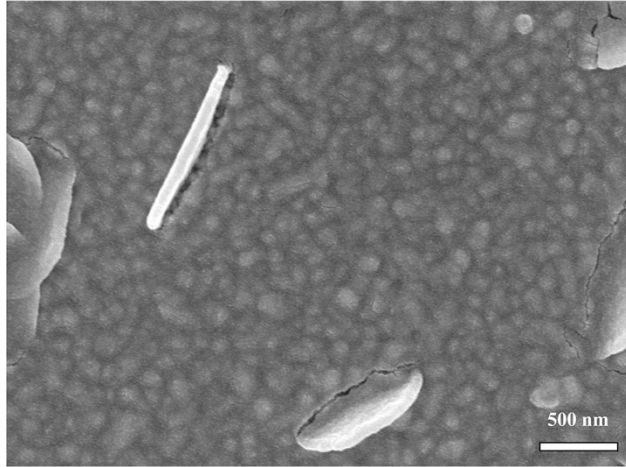
**Fig. S2** XRD diffraction of  $\text{Ni}(\text{acac})_2$  and  $\text{Co}(\text{acac})_2$ .



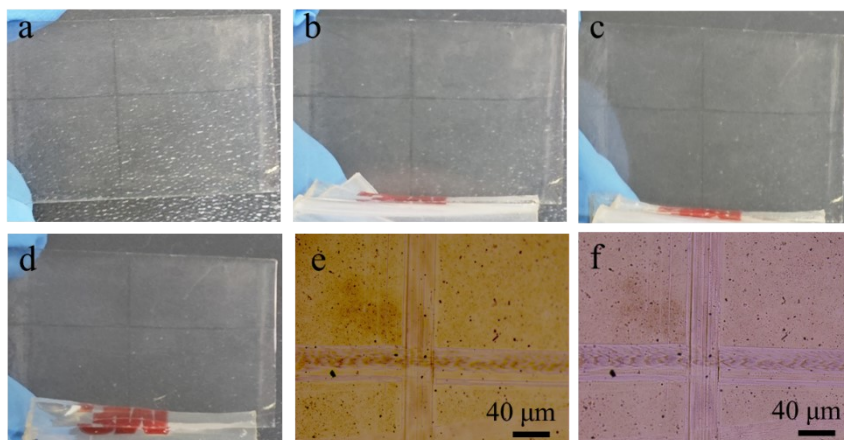
**Fig. S3** FTIR spectra of the NiCoO<sub>2</sub> precipitate at the wavenumber of 400 to 4000 cm<sup>-1</sup>.



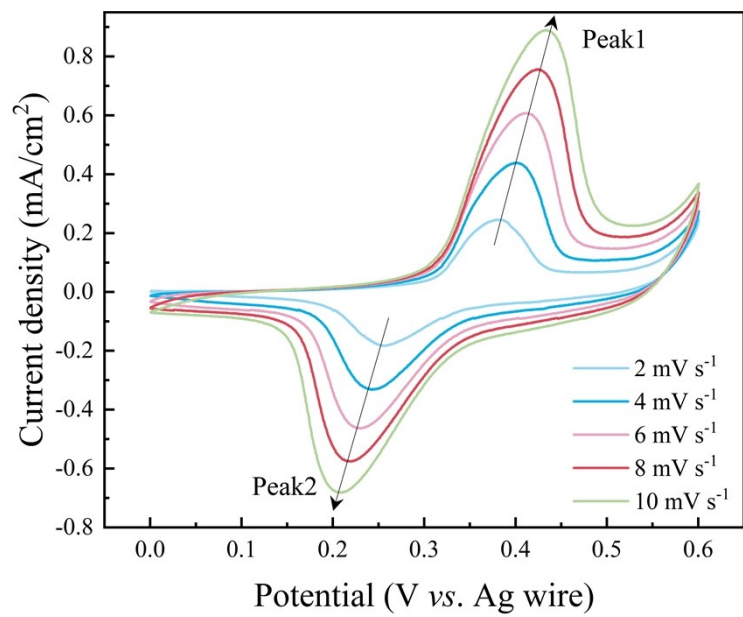
**Fig. S4** The XPS full spectrum of the NiCoO<sub>2</sub> thin film grown on FTO substrates.



**Fig. S5** SEM image of the NiCoO<sub>2</sub> thin film.

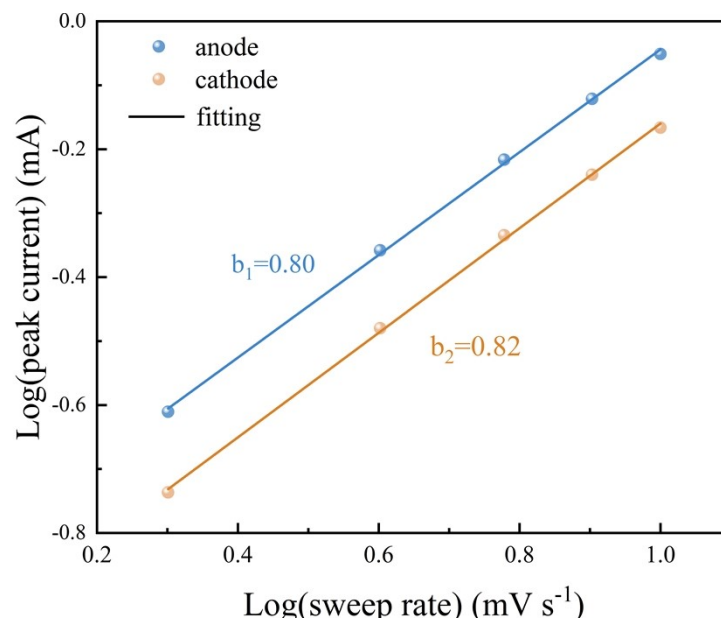


**Fig. S6** Tape peeling test of the NiCoO<sub>2</sub> thin film: Digital photos of the film without peeling (a), peeling once (b), peeling twice (c), and peeling thrice (d), respectively; Optical microscope images of the NiCoO<sub>2</sub> thin film before (e) and after (f) tape peeling thrice.

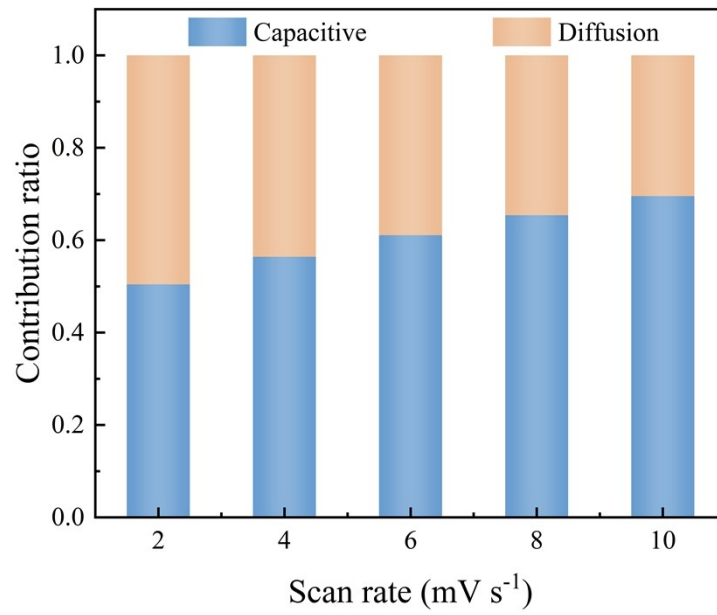


**Fig. S7** CV curves of film at different scan rates from 2 to 10 mV s<sup>-1</sup>.

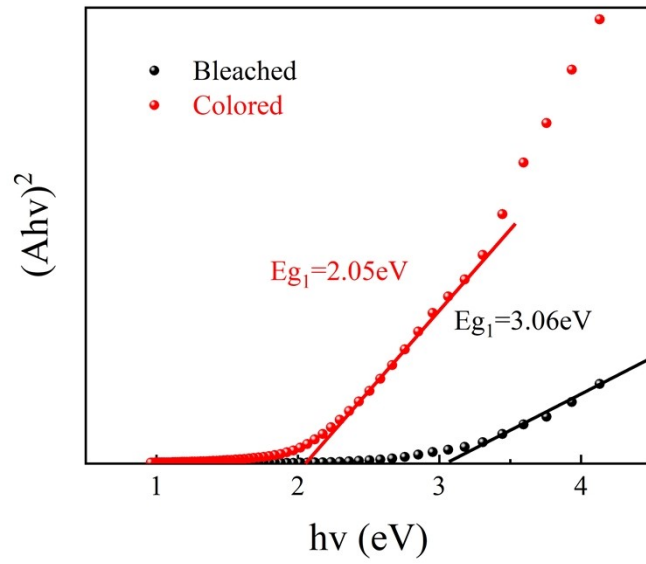




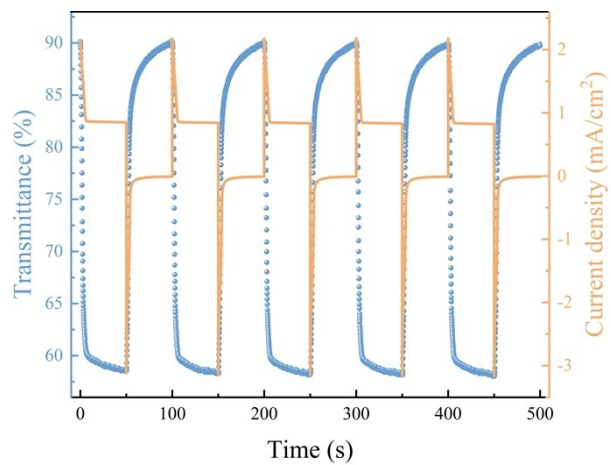
**Fig. S8** Calculation of b value according to the relationship between  $\log(v)$  and  $\log(i)$ .



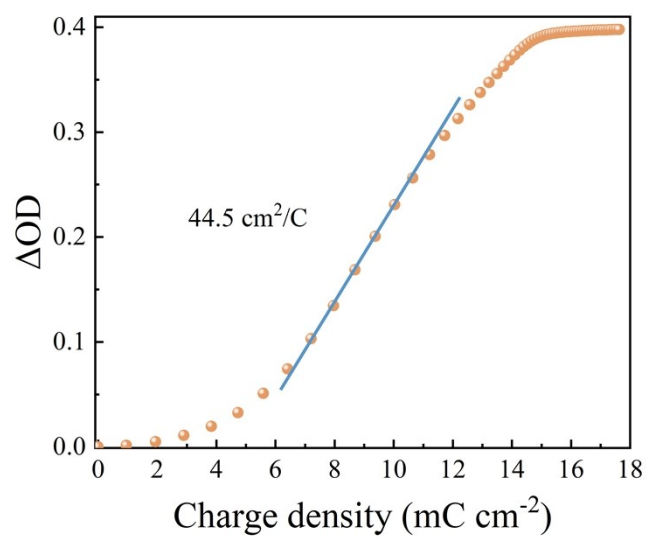
**Fig. S9** Capacitive and diffusion contributions of the film at different scan rates.



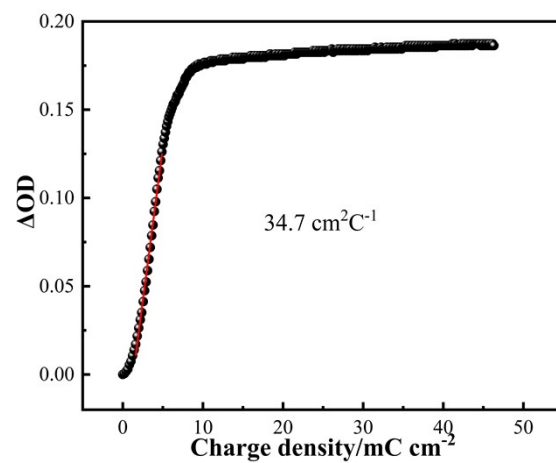
**Fig. S10** The optical band gap of NiCoO<sub>2</sub> thin film in the colored and bleached states.



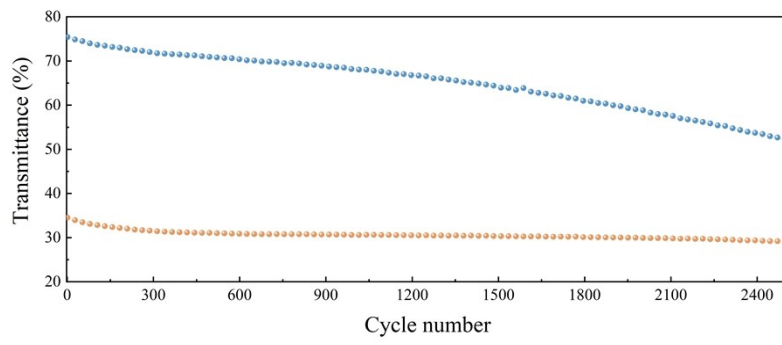
**Fig. S11** Current response and in situ transmittance response spectra of the film at 900 nm by applying square wave potentials of -0.2 and 0.6 V.



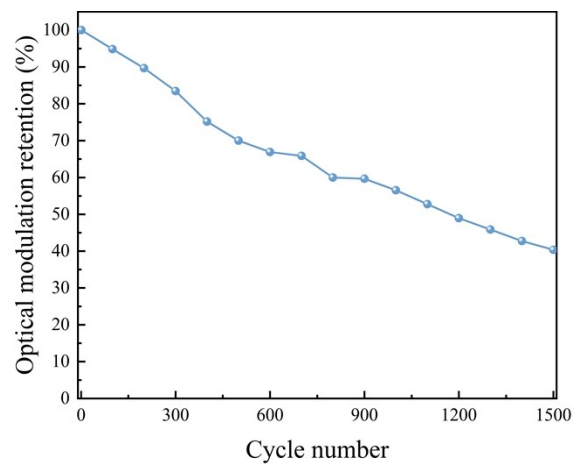
**Fig. S12** Coloration efficiency of the NiCoO<sub>2</sub> thin film in 1 M KOH electrolyte at 550 nm.



**Fig. S13** Coloring efficiency of the film at 900 nm.

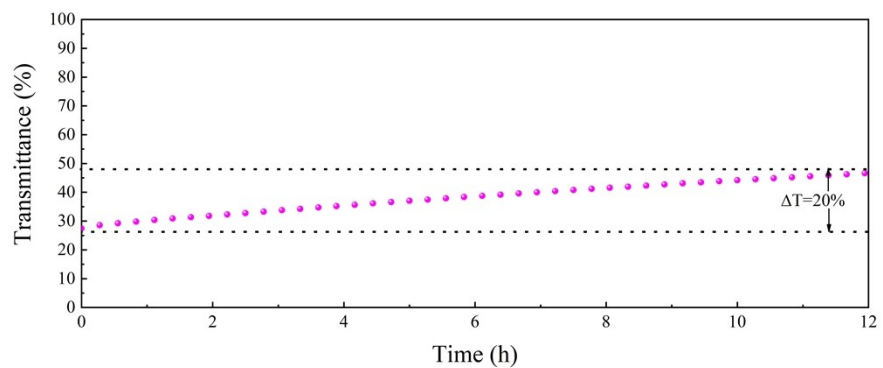


**Fig. S14** Cycling stability of NiCoO<sub>2</sub> thin films in 1M KOH electrolyte for 2500 cycles at 550 nm.

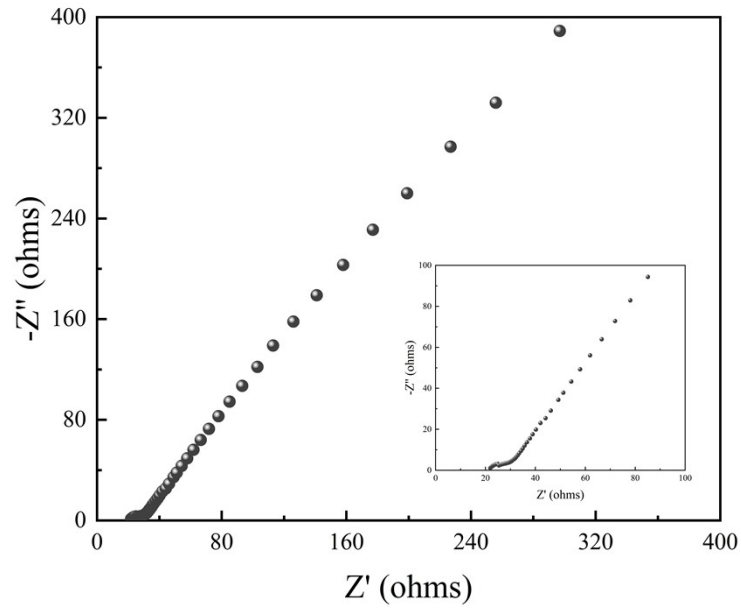


**Fig. S15** Cycling stability of the films at 900 nm for 1500 cycles.

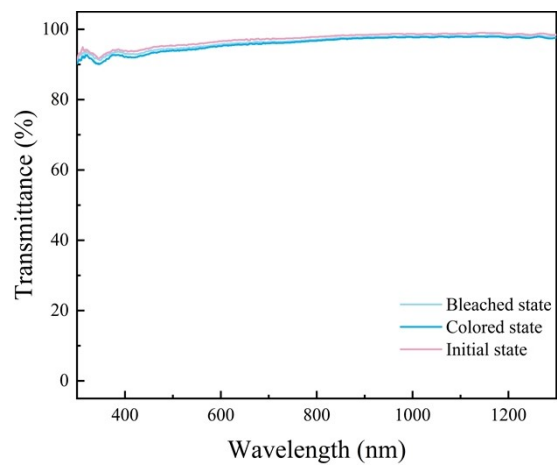




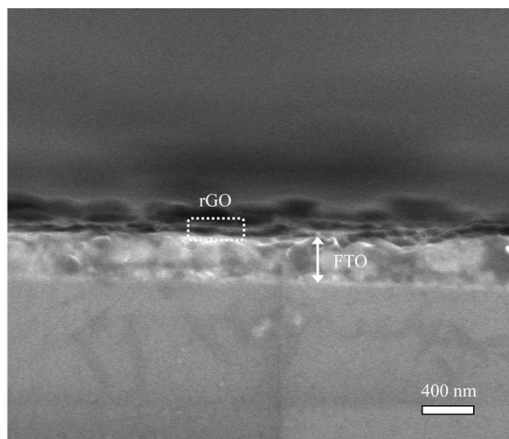
**Fig. S16** Optical memory of NiCoO<sub>2</sub> thin films in the colored state at 550 nm under open-circuit potential.



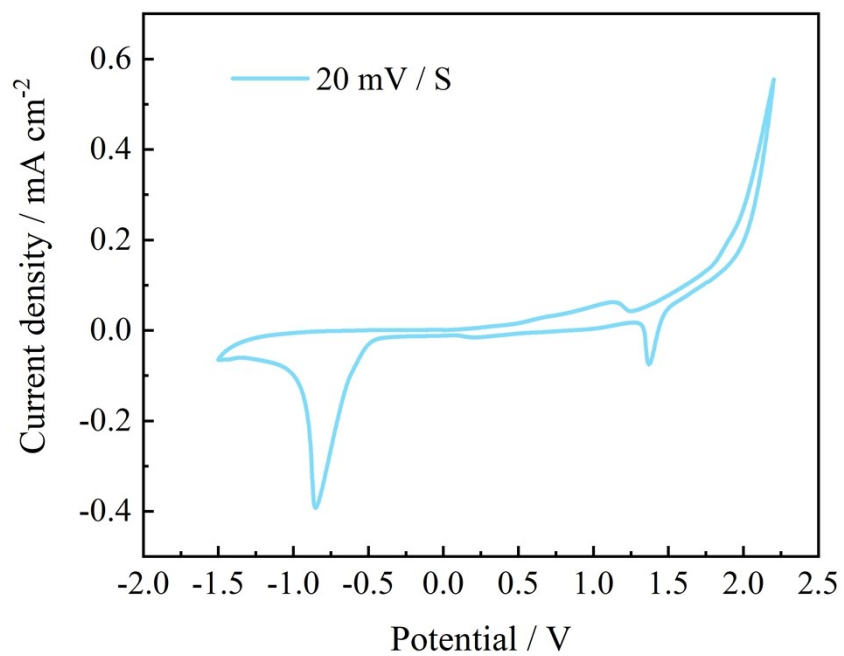
**Fig. S17** Nyquist plots of the NiCoO<sub>2</sub> film.



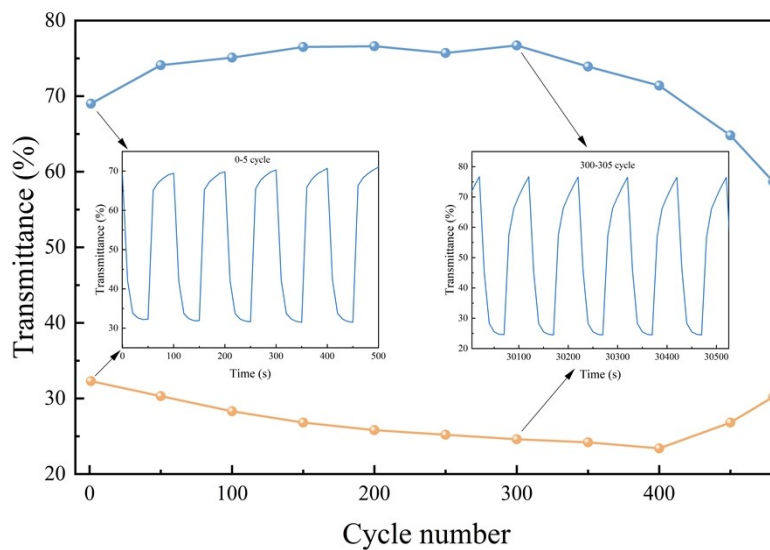
**Fig. S18** Transmittance spectra of the rGO film in the bleached state (-0.8 V vs. Ag wire) and colored state (0.6 V vs. Ag wire) .



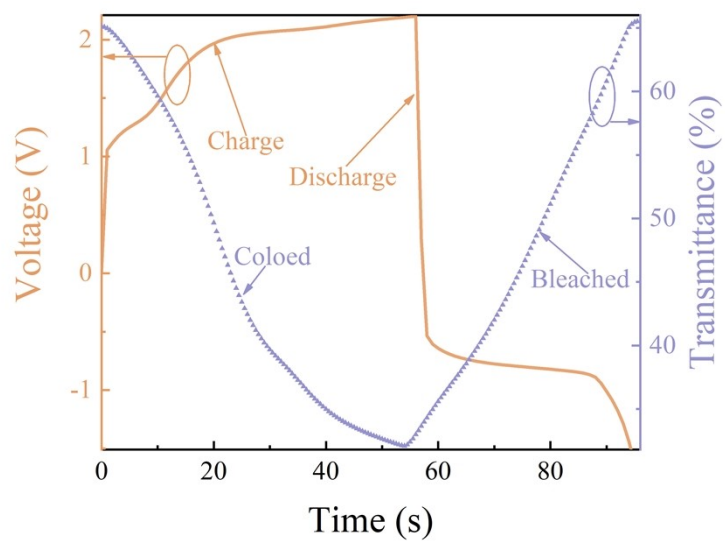
**Fig. S19** Cross-sectional image of the rGO film on the FTO substrate.



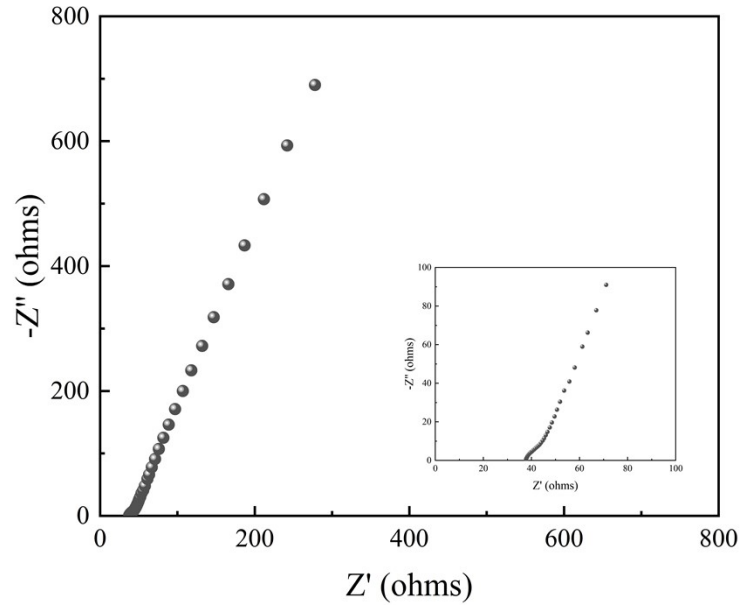
**Fig. S20** CV curve of the electrochromic energy storage device at a scan rate of 20 mV/s.



**Fig. S21** Cycling stability of the device in 1M KOH over 480 cycles.



**Fig. S22** GCD curve of the electrochromic energy storage device at a current density of 0.32 mA/cm<sup>2</sup>, accompanied by in situ dynamic spectrum at 550 nm.



**Fig. S23** Nyquist plots of the assembled EESD.





**Fig. S24** Measured voltage of two devices in series in the colored state.

**Table S1** Quantitative XPS analysis of NiCoO<sub>2</sub> thin films.

Name	Position	Area	FWHM	%At Conc
Ni 2p	851.00	56988.85	4.35	10.41
Co 2p	776.00	54765.59	6.01	11.27
C 1s	280.00	13429.41	3.60	35.69
O 1s	526.00	45011.66	3.79	42.63

**Table S2** The fitting parameters of NiCoO<sub>2</sub> thin films.

Name	Ni <sup>2+</sup>		Ni <sup>3+</sup>		Ni <sub>sat.1</sub>	Ni <sub>sat.2</sub>	Ni <sub>sat.3</sub>	Ni <sub>sat.4</sub>	Co <sup>2+</sup>		Co <sup>3+</sup>		Co <sub>sat.1</sub>	Co <sub>sat.2</sub>
	2p1/2	2p3/2	2p1/2	2p3/2					2p1/2	2p3/2	2p1/2	2p3/2		
Position (eV)	867.8	849.9	869.3	851.6	856.9	874.8	861.2	878.0	797.0	781.2	795.3	779.6	784.5	802.1
Area	75764	151529	216170	432340	475261	290519	41584	40084	5262	9315	6247	10112	35920	16270
FWHM	2.1	1.5	3.2	2.6	4.5	5.4	3.3	3.9	2.5	2.6	2.3	2.0	9.8	7.1

**Table S3** Quantitative analysis of NiCoO<sub>2</sub> thin films by elemental mapping.

Element	Ray type	Apparent concentration	K ratio	wt%	wt% Sigma	Atomic percentage
O	K-line system	2.03	0.00683	3.41	0.07	67.64
Si	K-line system	0.53	0.00418	0.59	0.01	6.69
Co	K-line system	0.30	0.00303	0.32	0.03	1.71
Ni	K-line system	0.34	0.00335	0.34	0.03	1.81
Sn	K-line system	7.30	0.07302	8.28	0.07	22.14

**Table S4** The property comparison of the NiCoO<sub>2</sub> electrode with other reported works

Ref.	Materials	Optical modulation	Memory properties	Cyclic stability	Areal capacitance
This work	NiCoO <sub>2</sub>	54.7% (550 nm) 34.8% (900 nm)	12 h (20%)	1500 (85%) 2500 (60%)	3.16 $\mu$ Ah/cm <sup>2</sup> (0.02 mA/cm <sup>2</sup> )
Ref. <sup>2</sup>	NiO	37.8% (550 nm)	24 h (36%)	1000 (91%)	5.72 $\times 10^{-2}$ mAh/cm <sup>2</sup> (0.1 mA/cm <sup>2</sup> )
Ref. <sup>3</sup>	NiCoO <sub>2</sub>	64.2% (550 nm) 41.8% (1000 nm)	6.7 h (11.4%)	500 (75%)	33.6 mAh/g (0.25A/g)
Ref. <sup>1</sup>	NiO	30.0% (550 nm)	-	-	-
Ref. <sup>4</sup>	NiO	41.8% (650 nm)	-	10000 (86%)	2.08 F/cm <sup>2</sup> (1 mA/cm <sup>2</sup> )
Ref. <sup>5</sup>	Co <sub>3</sub> O <sub>4</sub>	38% (633 nm)	-	-	-
Ref. <sup>6</sup>	Co <sub>3</sub> O <sub>4</sub>	13.9% (550 nm)	-	5 (100%)	99.67 F/g (0.5 A/g)
Ref. <sup>7</sup>	NiCoO <sub>2</sub>	60% (550 nm)	0.8 h (32.6%)	1000 (62%)	194.5 mAh/cm <sup>2</sup> (0.04 mA/cm <sup>2</sup> )
Ref. <sup>8</sup>	Co <sub>3</sub> O <sub>4</sub> /NiO	65.2% (600 nm)	-	300 (<90%)	-
Ref. <sup>9</sup>	Co(OH) <sub>2</sub> /Ni(OH) <sub>2</sub>	~20% (900 nm)	600 s (1%)	4000 (75%)	14.66 mF/cm <sup>2</sup> (0.2 mA/cm <sup>2</sup> )
Ref. <sup>10</sup>	Ni <sub>8</sub> -Co <sub>2</sub> oxide	49% (600 nm)	3000 s (10%)	1000 (49%)	-
Ref. <sup>11</sup>	Ni-Co oxide	55% (800 nm)	3000 s (<5%)	1000 (100%)	-

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